

## MMBTA43

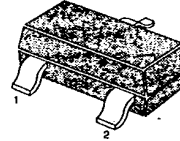
## NPN EPITAXIAL SILICON TRANSISTOR

## HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ( $T_a = 25^\circ\text{C}$ )

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	$V_{CB0}$	200	V
Collector-Emitter Voltage	$V_{CE0}$	200	V
Emitter-Base Voltage	$V_{EB0}$	6	V
Collector Current	$I_C$	500	mA
Collector Dissipation	$P_C$	350	mW
Storage Temperature	$T_{stg}$	150	$^\circ\text{C}$

SOT-23



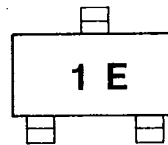
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ( $T_a = 25^\circ\text{C}$ )

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	$BV_{CB0}$	$I_C = 100\mu\text{A}, I_E = 0$	200		V
*Collector-Emitter Breakdown Voltage	$BV_{CE0}$	$I_C = 1\text{mA}, I_B = 0$	200		V
Emitter-Base Breakdown Voltage	$BV_{EB0}$	$I_E = 100\mu\text{A}, I_C = 0$	6		V
Collector Cutoff Current	$I_{CB0}$	$V_{CB} = 160\text{V}, I_E = 0$		100	nA
Emitter Cutoff Current	$I_{EB0}$	$V_{EB} = 4\text{V}, I_C = 0$		100	nA
*DC Current Gain	$h_{FE}$	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	25		
		$V_{CE} = 10\text{V}, I_C = 10\text{mA}$	40		
		$V_{CE} = 10\text{V}, I_C = 30\text{mA}$	40		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 20\text{mA}, I_B = 2\text{mA}$		0.5	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 20\text{mA}, I_B = 2\text{mA}$		0.9	V
Current Gain-Bandwidth Product	$f_T$	$I_C = 10\text{mA}, V_{CE} = 20\text{V}$ $f = 100\text{MHz}$	50		MHz
Collector-Base Capacitance	$C_{cb}$	$V_{CB} = 20\text{V}, I_E = 0$ $f = 1\text{MHz}$		4	pF

\*Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ 

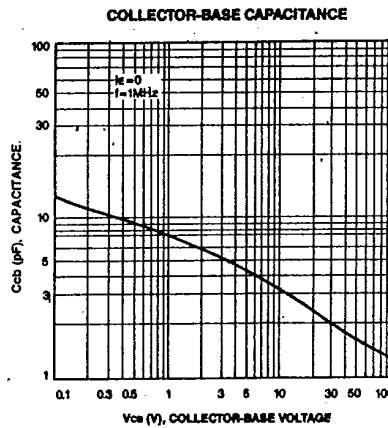
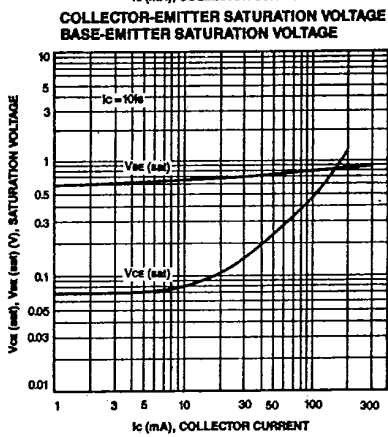
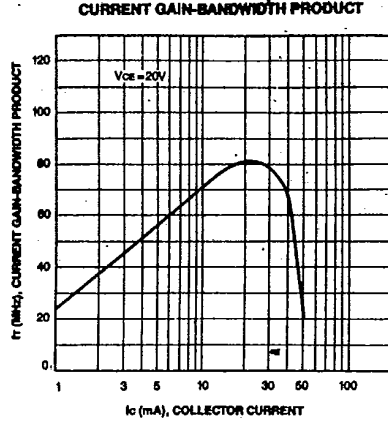
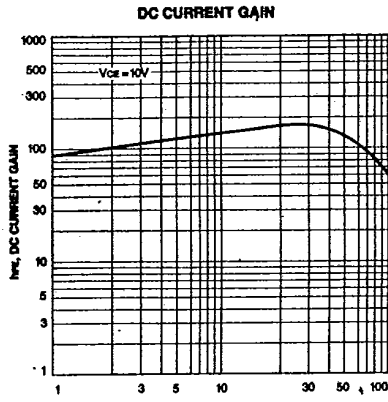
Marking



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NPN EPITAXIAL SILICON TRANSISTOR

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